## Notice of References Cited Application/Control No. 10/808,537 Applicant(s)/Patent Under Reexamination ODA ET AL. Examiner Yuk C. Chow Applicant(s)/Patent Under Reexamination ODA ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,028,745 A	07-1991	Yamanami et al.	178/18.07
*	В	US-5,434,372 A	07-1995	Lin, Chyi-Cheng	178/18.07
*	С	US-5,567,920 A	10-1996	Watanabe et al.	178/18.07
*	D	US-5,635,684 A	06-1997	Fukuzaki, Yasuhiro	178/18.07
*	E	US-5,675,130 A	10-1997	Sekizawa, Yasushi	178/18.07
*	F	US-5,682,019 A	10-1997	Katsurahira et al.	178/18.07
*	G	US-5,691,513 A	11-1997	Yamamoto et al.	178/18.07
*	Н	US-6,020,849 A	02-2000	Fukuzaki, Yasuhiro	342/374
*	ı	US-6,396,005 B2	05-2002	Rodgers et al.	178/18.01
*	J	US-6,670,561 B2	12-2003	Aoki, Toshio	178/18.01
*	К	US-6,888,538 B2	05-2005	Ely et al.	345/173
*	L	US-2005/0104865 A1	05-2005	Oda et al.	345/173
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N			- 3 -		
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	Р					
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	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	<b>v</b>	
	w	
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